Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/712,687	MIWA, AKIHIRO	
Examiner	Art Unit	_
Jianchun Qin	2837	

SEARCHED			
Class	Subclass	Date	Examiner
84	600,615, 645		H
	470,477R		
345	157		
715	856	7/6/2005	56
Above	updated	2/13/06	50
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search	7/06/05	50
EAST text Search updated	थाइदि	TO
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